

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination FUKAYA ET AL.	
		Examiner Lien T. Tran	Art Unit 1761	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,466,985	08-1984	Tsen et al.	426/131
*	B	US-6,017,572	01-2000	Meyer, Richard S.	426/521
*	C	US-5,916,620	06-1999	Oh, Nam H.	426/557
*	D	US-5,702,745	12-1997	Yang et al.	426/242
*	E	US-5,332,587	07-1994	Howard et al.	426/128
*	F	US-4,734,291	03-1988	Raffensperger, Stanley P.	426/325
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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